Application/Control No. Applicant(s)/Patent Under Reexamination 09/849,136 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tom P Duong 1764 **U.S. PATENT DOCUMENTS Document Number** Date Name Country Code-Number-Kind Code MM-YYYY Classification US-4,188,592 Α 02-1980 Buczek et al. 372/89 В US-4,397,823 08-1983 Dimpfl, William L. 423/210 С US-5,965,786 10-1999 Rostaing et al. 588/210 D US-Е US-F US-US-G US-Н US-1 J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W.

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